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Renesas Technology Corp.
Customer Support Dept.
April 1, 2003

Cautions

Keep safety first in your circuit designs!

1. Renesas Technology Corporation puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal injury, fire or property damage.

Remember to give due consideration to safety when making your circuit designs, with appropriate measures such as (i) placement of substitutive, auxiliary circuits, (ii) use of nonflammable material or (iii) prevention against any malfunction or mishap.

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H5N6001P

Silicon N-Channel MOSFET
High-Speed Power Switching

RENESAS

ADE-208-1425A (Z)

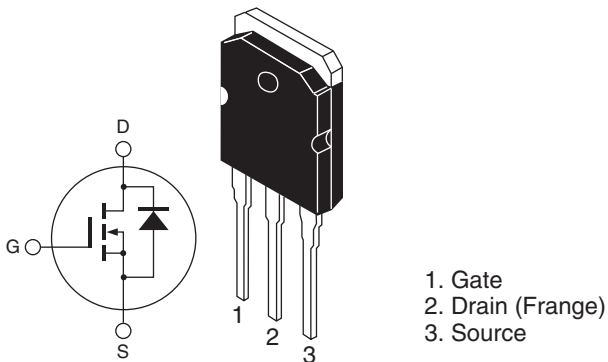
2nd. Edition
May 2001

Features

- Low on-resistance
- Low leakage current
- High speed switching
- Low gate charge (Qg)

Outline

TO-3P



Absolute Maximum Ratings (Ta = 25°C)

| Item | Symbol | Value | Unit |
|---|--------------------------------|-------------|------|
| Drain to source voltage | V_{DSS} | 600 | V |
| Gate to source voltage | V_{GSS} | ±30 | V |
| Drain current | I_D | 20 | A |
| Drain peak current | I_D (pulse) ^{*1} | 80 | A |
| Body-drain diode reverse drain current | I_{DR} | 20 | A |
| Body-drain diode reverse drain peak current | I_{DR} (pulse) ^{*1} | 80 | A |
| Avalanche current | I_{AP} ^{*3} | 6.5 | A |
| Channel dissipation | Pch ^{*2} | 150 | W |
| Channel to case thermal inpedance | θ ch-c | 0.833 | °C/W |
| Channel temperature | Tch | 150 | °C |
| Storage temperature | Tstg | -55 to +150 | °C |

Notes: 1. PW ≤ 10 μs, duty cycle ≤ 1%

2. Value at Tc = 25°C

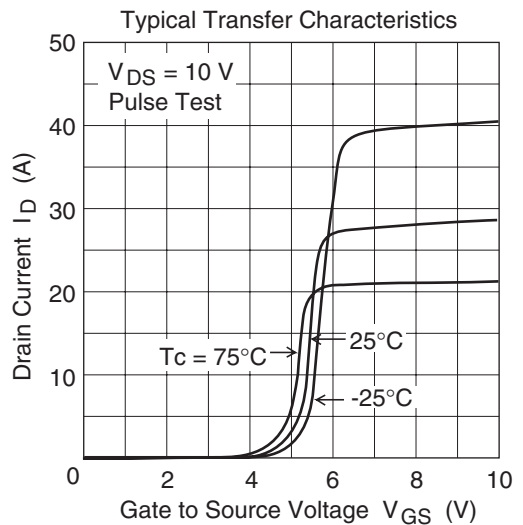
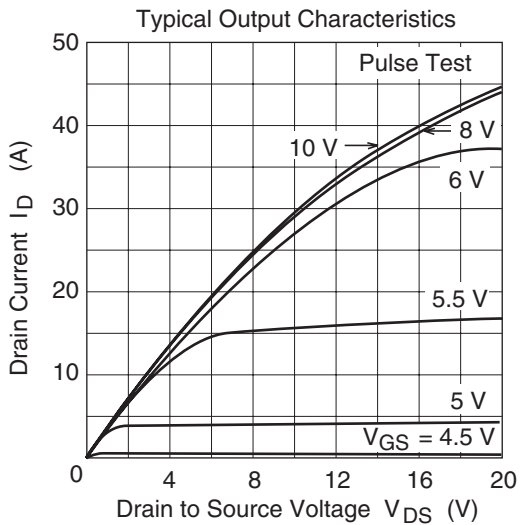
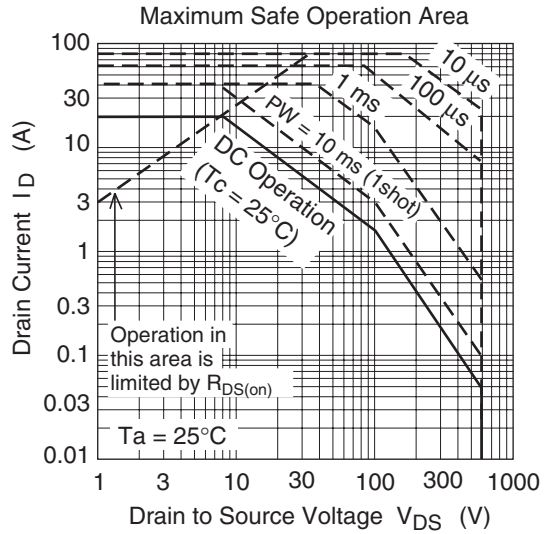
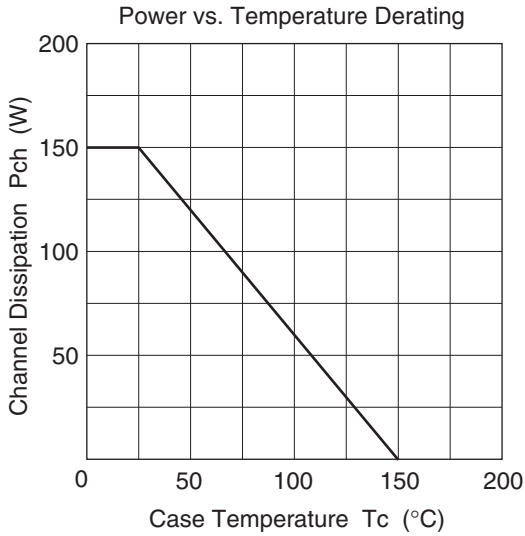
3. Tch ≤ 150°C

Electrical Characteristics (Ta = 25°C)

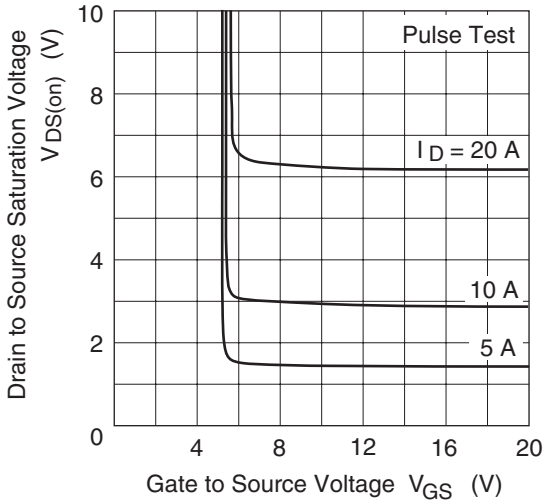
| Item | Symbol | Min | Typ | Max | Unit | Test conditions |
|--|---------------|-----|------|-----------|---------------|---|
| Drain to source breakdown voltage | $V_{(BR)DSS}$ | 600 | — | — | V | $I_D = 10 \text{ mA}$, $V_{GS} = 0$ |
| Zero gate voltage drain current | I_{DSS} | — | — | 1 | μA | $V_{DS} = 600 \text{ V}$, $V_{GS} = 0$ |
| Gate to source leak current | I_{GSS} | — | — | ± 0.1 | μA | $V_{GS} = \pm 30 \text{ V}$, $V_{DS} = 0$ |
| Gate to source cutoff voltage | $V_{GS(off)}$ | 3.0 | — | 4.0 | V | $V_{DS} = 10 \text{ V}$, $I_D = 1 \text{ mA}$ |
| Forward transfer admittance | $ y_{fs} $ | 12 | 20 | — | S | $I_D = 10 \text{ A}$, $V_{DS} = 10 \text{ V}^{*4}$ |
| Static drain to source on state resistance | $R_{DS(on)}$ | — | 0.30 | 0.38 | Ω | $I_D = 10 \text{ A}$, $V_{GS} = 10 \text{ V}^{*4}$ |
| Input capacitance | C_{iss} | — | 4640 | — | pF | $V_{DS} = 25 \text{ V}$ |
| Output capacitance | C_{oss} | — | 340 | — | pF | $V_{GS} = 0$ |
| Reverse transfer capacitance | C_{rss} | — | 70 | — | pF | $f = 1 \text{ MHz}$ |
| Turn-on delay time | $t_{d(on)}$ | — | 60 | — | ns | $V_{DD} \cong 300 \text{ V}$, $I_D = 10 \text{ A}$ |
| Rise time | t_r | — | 100 | — | ns | $V_{GS} = 10 \text{ V}$ |
| Turn-off delay time | $t_{d(off)}$ | — | 220 | — | ns | $R_L = 30 \Omega$ |
| Fall time | t_f | — | 90 | — | ns | $R_g = 10 \Omega$ |
| Total gate charge | Q_g | — | 135 | — | nC | $V_{DD} = 480 \text{ V}$ |
| Gate to source charge | Q_{gs} | — | 20 | — | nC | $V_{GS} = 10 \text{ V}$ |
| Gate to drain charge | Q_{gd} | — | 65 | — | nC | $I_D = 20 \text{ A}$ |
| Body-drain diode forward voltage | V_{DF} | — | 0.9 | 1.4 | V | $I_F = 20 \text{ A}$, $V_{GS} = 0$ |
| Body-drain diode reverse recovery time | t_{rr} | — | 590 | — | ns | $I_F = 20 \text{ A}$, $V_{GS} = 0$ $diF/dt = 100 \text{ A}/\mu\text{s}$ |
| Body-drain diode reverse recovery charge | Q_{rr} | — | 6.5 | — | μC | |

Note: 4. Pulse test

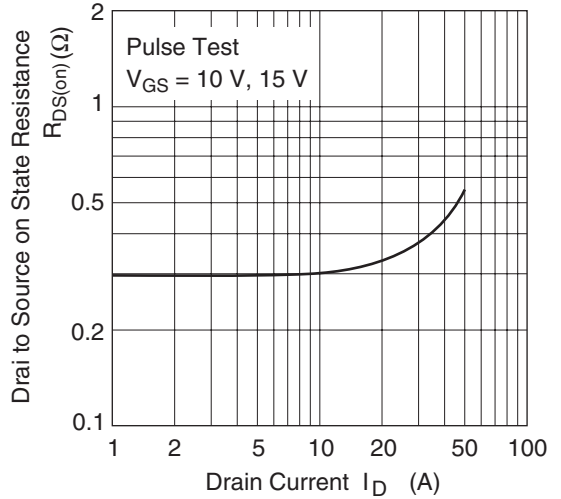
Main Characteristics



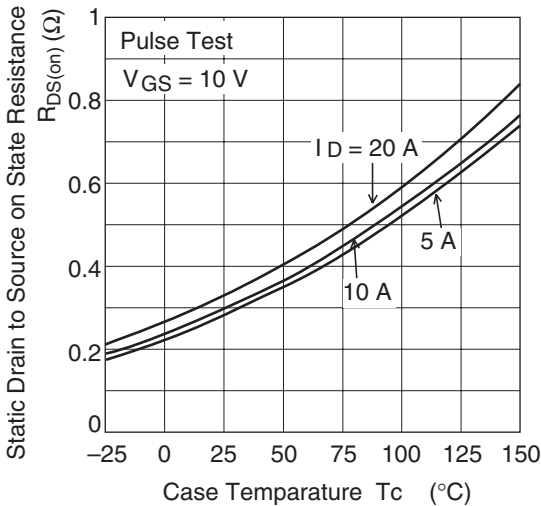
Drain to Source Saturation Voltage VS. Gate to Source Voltage



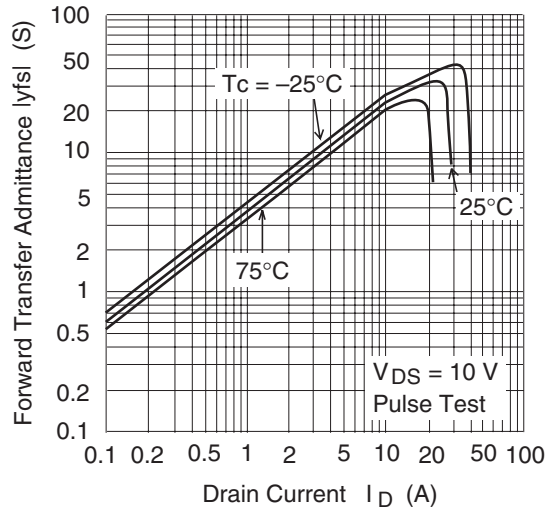
Static Drain to Source on State Resistance vs. Drain Current



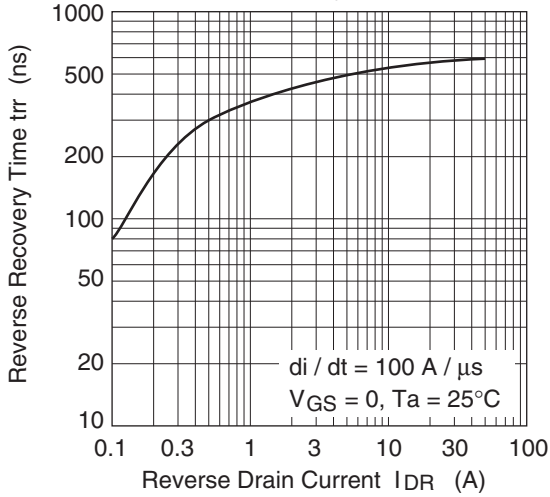
Static Drain to Source on State Resistance vs. Temperature



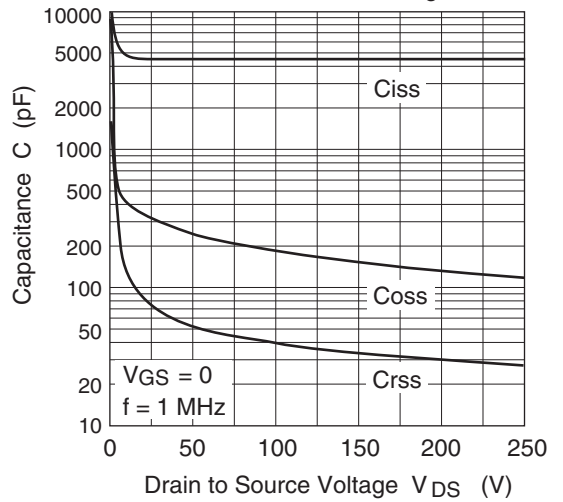
Forward Transfer Admittance vs. Drain Current



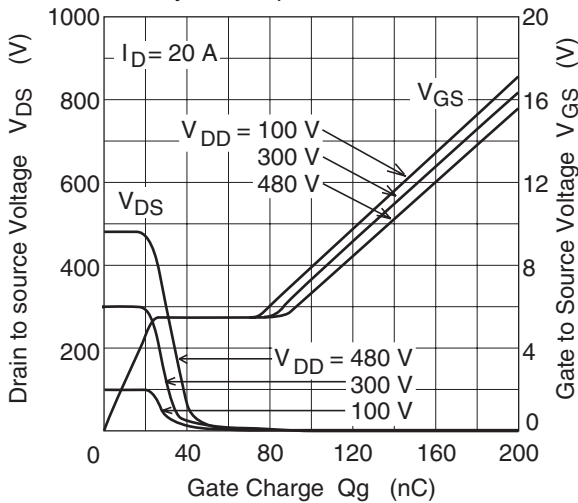
Body-Drain Diode Reverse Recovery Time



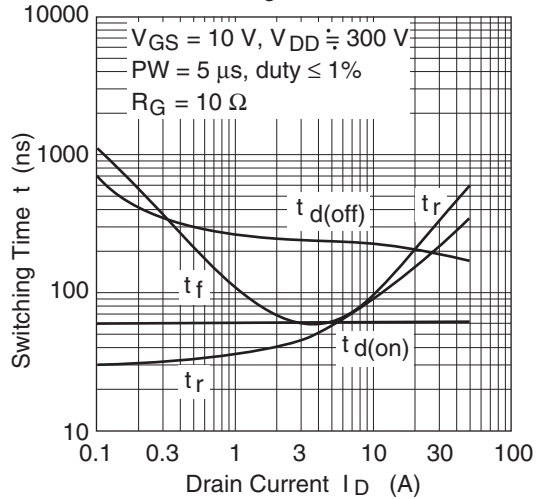
Typical Capacitance vs. Drain to Source Voltage



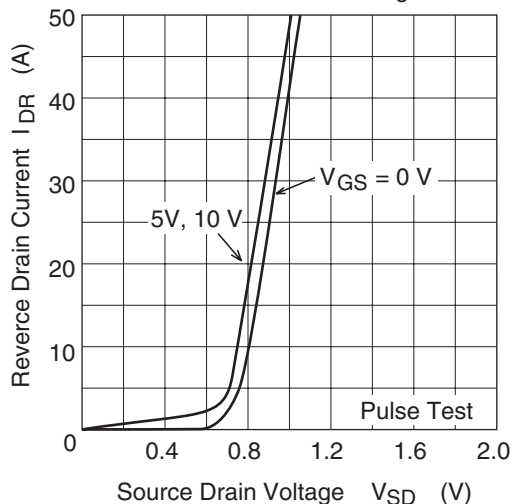
Dynamic Input Characteristics



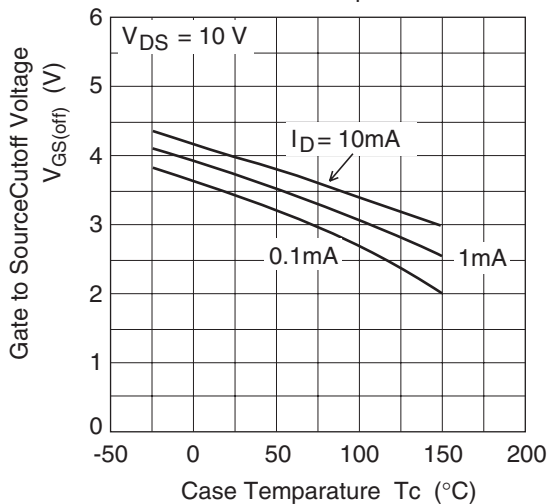
Switching Characteristics



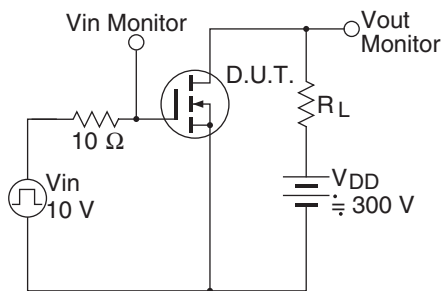
Reverse Drain Current vs. Source to Drain Voltage



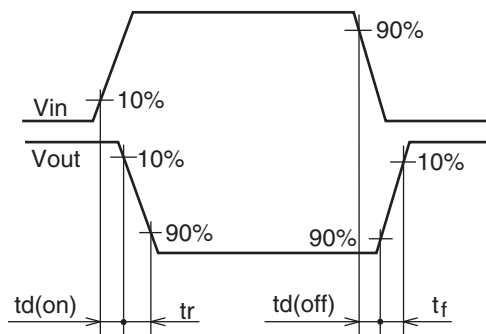
Gate to Source Cutoff Voltage vs. Case Temperature

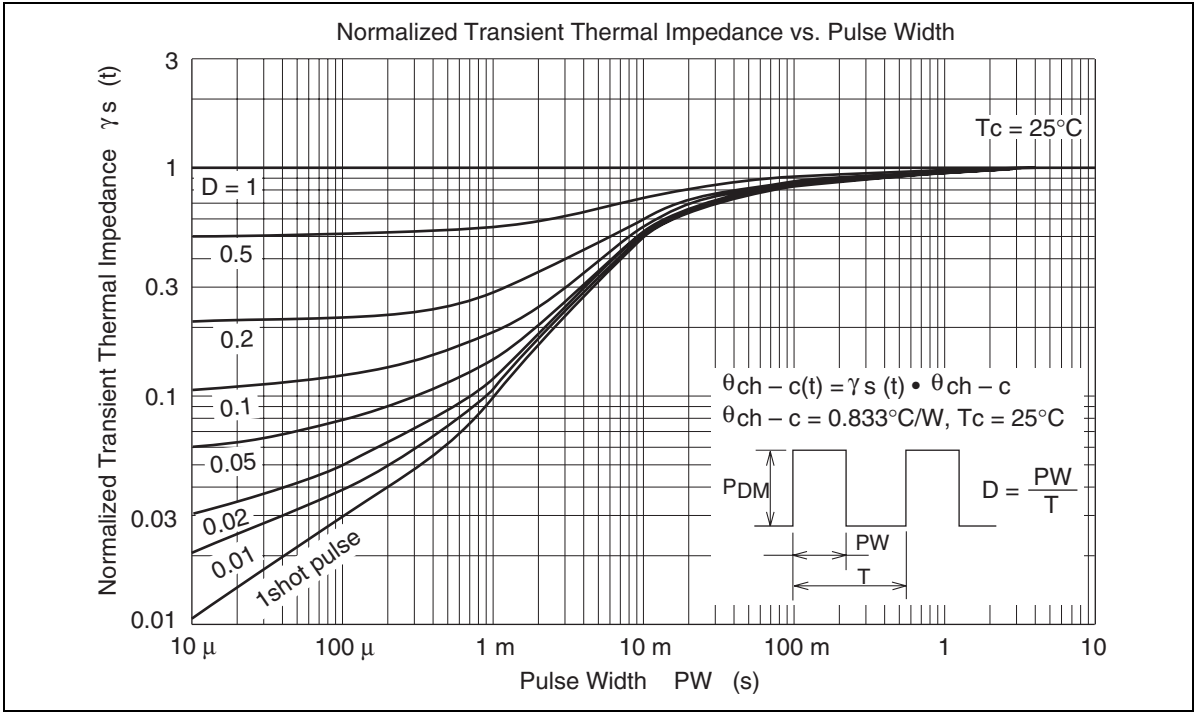


Switching Time Test Circuit

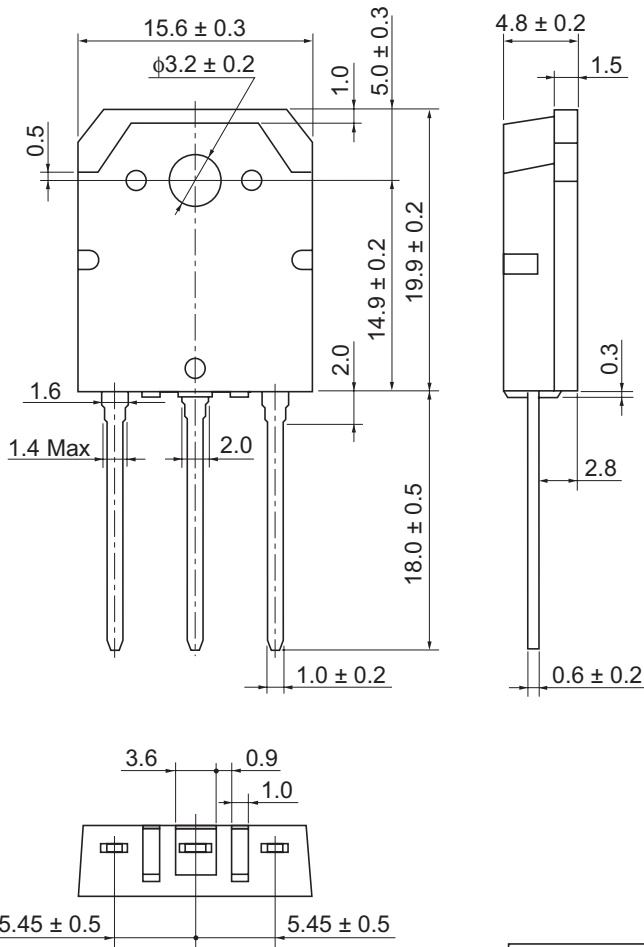


Waveform

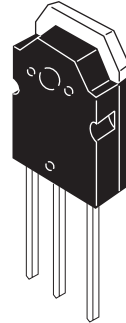




Package Dimensions



As of January, 2001
Unit: mm



| | |
|------------------------|----------|
| Hitachi Code | TO-3P |
| JEDEC | — |
| EIAJ | Conforms |
| Mass (reference value) | 5.0 g |

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